


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/781,180	TASAKA ET AL.	
	Examiner	Art Unit	
	HOAN C. NGUYEN	2871	

SEARCHED			
Class	Subclass	Date	Examiner
349	123	3/15/2007	CHN
349	127-130	3/15/2007	CHN
349	132-135	3/15/2007	CHN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
US - PG PUB, US PAT, EPO, JPO.		